Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/811,811	TAKEDA ET AL.
Examiner	Art Unit
Matthew C. Landau	2815

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SEARCHED						
Class	Subclass	Date	Examiner			
257	394,345 400	5/16/07	~~			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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